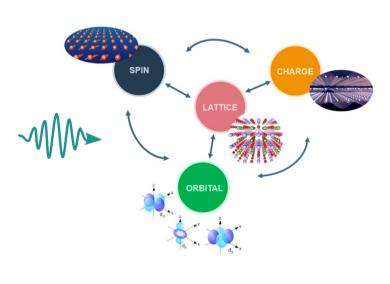
# **SCS** instrument

# European XFEL Virtual User Information Meeting, Oct. 10<sup>th</sup>, 2023 12<sup>th</sup> Call for Proposals



Andreas Scherz, SCS instrument



European XFEL





> Facility > Instruments > SCS

### Scientific Instrument SCS



### 12th Call for User Proposals

spectrometer for X-ray diffraction, reflection, and resonant inelastic X-ray scattering experiments. The lowest photon energy at SASE3 includes the N K-edge. Detailed parameters is November 8th, 2023 at 4pm (CET). Please note that the FFT and CHEM station is NOT offered in this semester call.

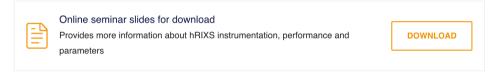
contact us: scs@xfel.eu

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### 12th-Call-for-Proposals: XRD & hRIXS



### Online hRIXS Seminar: Information about hRIXS instrumentation



### hRIXS instrumentation and information

We commissioned the hRIXS spectrometer during Spring period 2021 reaching up to 10,000 resolving power in a photon energy range between oxygen K edge and Cu L edges (0.5-1.0 keV). After a successful period of user-assisted commissioning in Februar and March of 2022, we will welcome first regular users scheduled for the second half of 2022. The XRD and CHEM experiment stations are available to users providing solid and liquid sample environments, respectively. For more information we refer to the agenda and information on the **online seminar** page, which we hosted on Oct 21st, 2021 at 5pm (CEST) to present users the outcome of the RIXS commissioning at the SCS instrument.

### Scientific Instrument SCS: XRD and RIXS

# **SCS** instrument

# XRD experiment station

### Spectroscopy and Coherent Scattering (SCS):

- High-rep-rate FEL soft x-ray instrument
- Time-resolved/ non-linear x-ray spectroscopies
- Time-resolved/ non-linear x-ray diffraction
- Resonant Inelastic X-ray Scattering (RIXS)
- Reflection- / backscattering geometries

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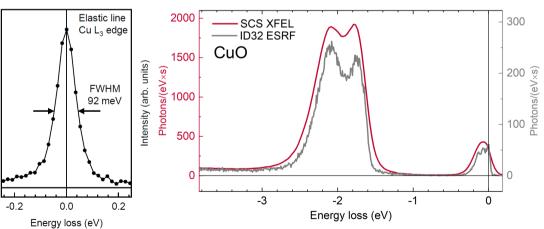
 Sample environment for condense matter samples

Heisenberg RIXS (hRIXS) spectrometer

### XRD experiment station and hRIXS spectrometer



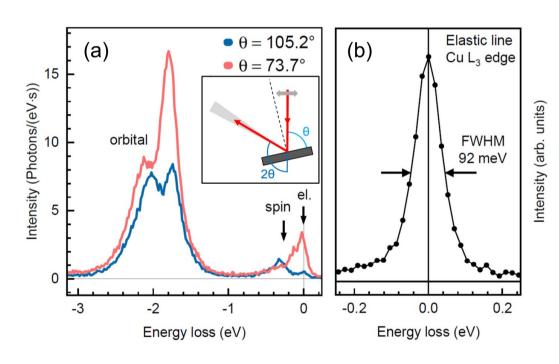
hRIXS parameters	
Photon energy	0.25 (0.45 SA3) - 1.5 keV
Combined resolving power	Up to 10.000 (mono HR) 3.000 (mono LR)
Transmission	~10 <sup>-6</sup>
Time resolution	Limited by mono: 80-150 fs (mono HR) 30-50 fs (mono LR)
Scattering angle	65 – 145 deg Default: 125 deg



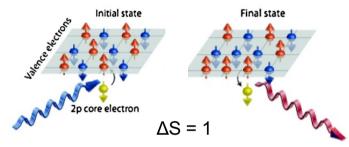
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# hRIXS x-ray commissioning: achieved energy resolution

Static RIXS from thin-film La<sub>2</sub>CuO<sub>4</sub> at Cu L<sub>3</sub> edge:



### **Spin excitations:**



L. Braicovich et al. PRL 102, 167401(2009)

H.C. Robarts et al. PRB 103, 224427 (2021)

Edge	Energy (eV)	Energy res. (meV)	E/AE
Cu L <sub>3</sub>	930	92	10 100
Ni L <sub>3</sub>	853	75	11 370
OK	530	49	10 400



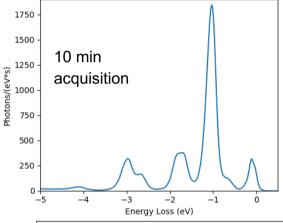
Achieved combined resolving power: > 10.000

# Count rates RIXS from NiO for high energy resolution

### **Static spectra at 1.1 MHz repetition rate:**

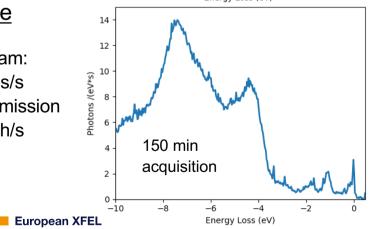
# Ni L<sub>3</sub>-edge

Incident Beam: 4,000 pulses/s 100% transmission 1.0 x 10<sup>13</sup> ph/s

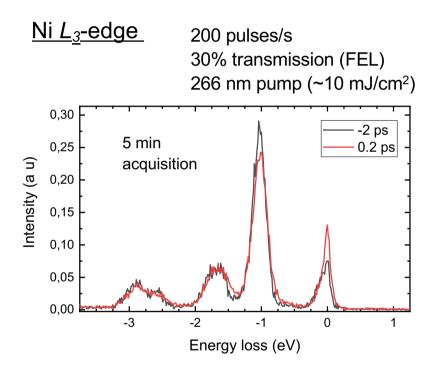


### O K-edge

Incident Beam: 4,000 pulses/s 100% transmission 1.6 x 10<sup>12</sup> ph/s



### Dynamic spectra at 113 kHz repetition rate:



- La2CuO4: count rate ~ factor 10 lower
- 1.1 MHz possible for 800, 400 and 266 nm pump
- 1000 I/mm grating: 4-5 times more throughput

# **Detector upgrade for hRIXS**

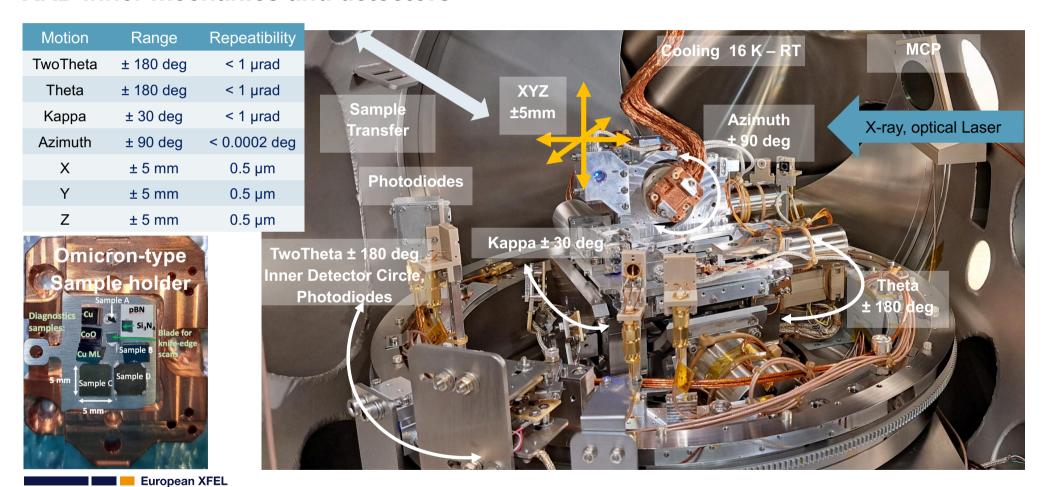
Marana-X (available for 2024-I onwards),

### **TRAIN-RESOLVED**

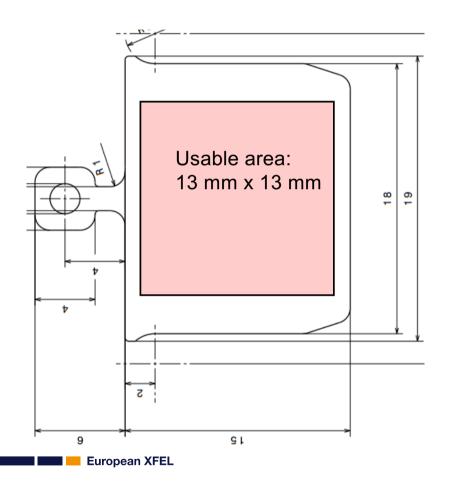
11µm pixel size and 48fps, Back-illuminated sCMOS EUV/soft X-ray camera

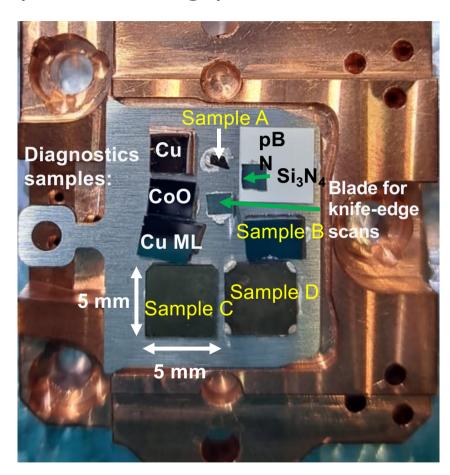


### **XRD** inner mechanics and detectors

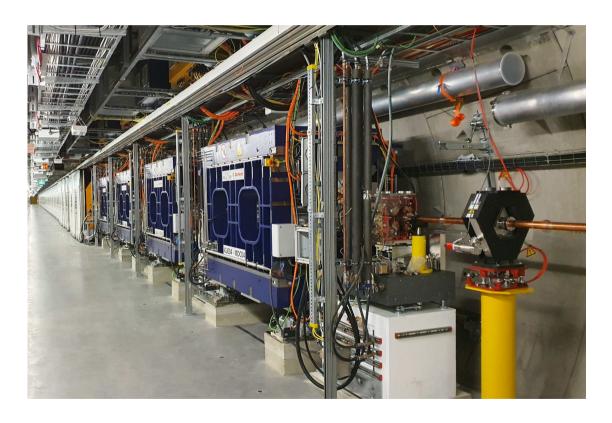


# Flag-style sample holder (Omicron design)





# EuXFEL APPLE-X (UE90) Variable Polarization at SA3: Linear horizontal, linear vertical, left and right circular Polarizations



re-install foreseen in winter 2023 -> commissioning in 2024-I

Polarization mode	LH/LV/C+/C-	
K-Range	9.59 – 3.38	
Photon Energy Range [keV]		
@8.5 GeV	0.163 – 1.137	
@11.5 GeV	0.299 – 2.082	
@14 GeV	0.443 - 3.085	
@16.5 GeV	0.615 – 4.286	
@17.5 GeV	0.692 – 4.821	

# **Optical laser parameters**

Optical laser system	SASE3 PP laser	
Center wavelength	800 nm	
Pulse duration	15 or 50 fs	
Repetition rate and Pulse energy	2 mJ @ 113 kHz, 800 nm 0.2 mJ @ 1.13 MHz, 800 nm	Possibly also 564kHz mode. Inquire for details
Wavelength tunability	Conversions from 800 nm / 50 fs: SHG (400 nm), THG (266 nm), OPA: wavelength between 350 nm and 2.5 microns Please inquire for details on pulse energies	
Spot size	rization Linear and circular	
Polarization		
Operation		

- Second and third harmonic generation from 800nm, 50fs to 400nm and 266nm
- 113 kHz
  - 800nm, 2 mJ/pulse
  - 400nm, 350 µJ/pulse
  - 266nm, 75 μJ/pulse
- 1.1 MHz
  - 800nm, 200 μJ/pulse
  - 400nm, 30 µJ/pulse,
    (typically use 25% of this)
  - 266nm, 1.5 μJ/pulse (aim for 20 μJ/pulse)



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### Scientific Instrument SCS



### 12th Call for User Proposals

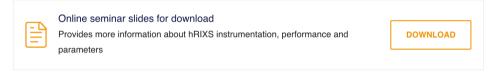
spectrometer for X-ray diffraction, reflection, and resonant inelastic X-ray scattering experiments. The lowest photon energy at SASE3 includes the N K-edge. Detailed parameters is November 8th, 2023 at 4pm (CET). Please note that the FFT and CHEM station is NOT offered in this semester call.

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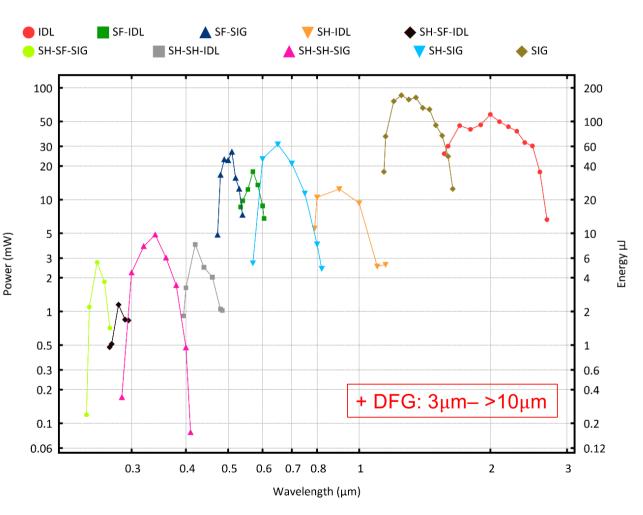
# PP laser information

# Frequency Conversion 1: SHG and THG

- Second and third harmonic generation from 800nm, 50fs to 400nm and 266nm
- 113 kHz
  - 800nm, 2 mJ/pulse
  - 400nm, 350 μJ/pulse
  - 266nm, 75 μJ/pulse
- 1.1 MHz
  - 800nm, 200 μJ/pulse
  - 400nm, 30 μJ/pulse, (typically use 25% of this)
  - 266nm, 1.5 μJ/pulse (aim for 20 μJ/pulse)

## Frequency Conversion 1: SHG and THG

- OPA (Light Conversion Topas)
  - Wide range of wavelengths allows e.g resonant pumping, above or below band gaps, ...
  - Repetition rate 113kHz, 50 fs, (1.1MHz, 50fs)
  - User experiments so far: UV (320nm), visible (550nm, 633nm), NIR (1300nm), IR (2500nm)



# Additional Information (Q&A session)

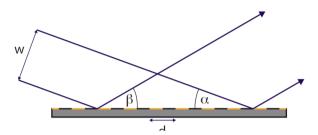
# **Monochromator settings SCS beamline:**

The use of monochromator leads to pulse stretching. Resolution has to be compromised for time resolution.

### **Low-resolution grating**

LR grating	
Line density	50 l/mm
Resolving power	3.000 (1st order)
Pulse stretching	30-50 fs
X-ray pulse energy	up to 30 μJ

- → Moderate combined energy resolution
- → High temporal resolution



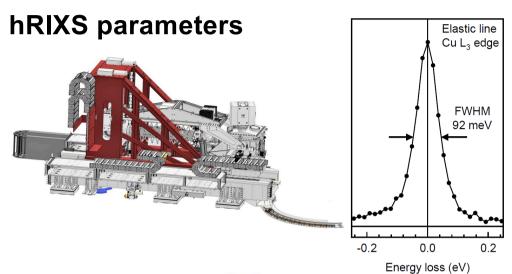
Time delay:  $\Delta \tau_{\rm rms} = \frac{1}{c} w_{\rm rms} d_0 \lambda$ 

### **High-resolution grating**

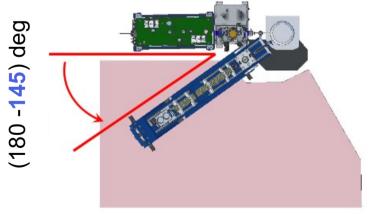
HR grating	
Line density	150 l/mm
Resolving power	Up to 10.000 (1st order)
Pulse stretching	80-150 fs
X-ray pulse energy	up to 5 μJ

- → High combined energy resolution
- → Moderate temporal resolution

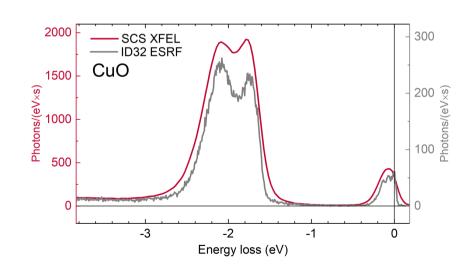
Gerasimova, et al., JSR, 29, 1299-1308 (2022).



	hRIXS parameters		
	Photon energy	0.25 (0.45 SA3) - 1.5 keV	
. units)	Combined resolving power	Up to 10.000 (mono HR) 3.000 (mono LR)	
ty (art	Transmission	~10 <sup>-6</sup>	
Intensity (arb.	Time resolution	Limited by mono: 80-150 fs (mono HR) 30-50 fs (mono LR)	
	Scattering angle	65 – 145 deg Default: 125 deg	



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# **Energy resolution: three working points**

There are two working points for the monochromator:

### (A) High transmission grating

Low Resolution (LR) grating:		
Line density	50 l/mm	
Resolving power	<b>3.000</b> (1 <sup>st</sup> order)	
Pulse stretching	30-50 fs	
X-ray pulse energy	up to 30 μJ	

- → High throughput, lower pulse stretching
- → Energy resolution limited by the mono

### (B) High resolution grating

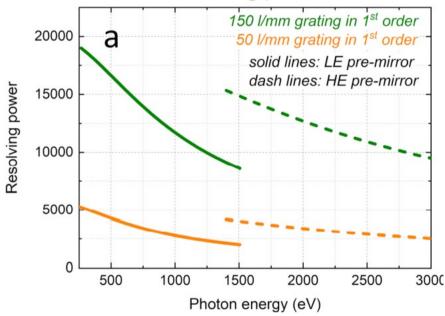
High Resolution (HR) grating:	
Line density	150 l/mm
Resolving power	> 10.000 (1st order)
Pulse stretching	80-150 fs
X-ray pulse energy	up to 5 μJ

- Can be used with:
- a) High-resolution RIXS grating (3000 l/mm)
- Resolving power >10.000, Transmission > 3%
- → Energy resolution limited by the mono
- b) High-transmission RIXS grating (1000 l/mm)
- Resolving power <10.000, Transmission > 12%
- → Expected combined resolving power of 6,000 7,000

# SCS instrument: photon energy, resolving power and beam size

### Two monochromator gratings:



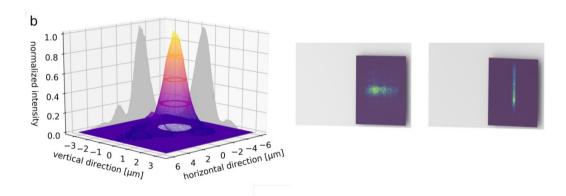


N. Gerasimova et al., J. Synchrotron Rad. 29, 1299 (2022)

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Variable beam size due to bendable KB mirrors:

beam width from 1 µm - 1 mmsymmetric or line shape



G. Mercurio et al., Opt. Express 30, 20980 (2020)

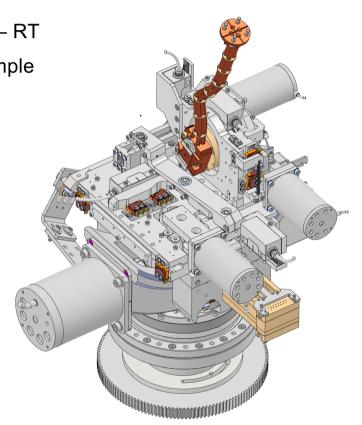
# XRD setup: sample environment

UHV ( $p < 10^{-9} \text{ mbar}$ )

Cryogenic temperatures: 16 K – RT

6 degrees of motion for the sample

Motion	Range
Azimuth	± 90 deg
X	± 5 mm
Υ	± 5 mm
Z	± 5 mm
Kappa (tilt)	± 30 deg
Theta	± 180 deg
TwoTheta	± 180 deg

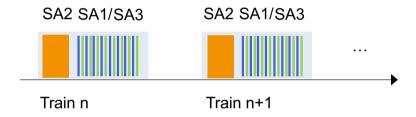


### **FEL pulse pattern**

- Pulse train at 10 Hz, Burst mode with 400 µs for SCS, Repetition rate variable up to 1.1 MHz
- o PP laser: also burst mode (the same pattern as FEL)

### Interleaved mode with SA1:

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Repetition rate of up to 1.1 MHz for SCS

